

Notice of References Cited

Application Control No
09/701,013

Applicant(s) Patent Under Reexam
Terada et al.

Examiner
Shin-Lin Chen

Art Unit
1633

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U.S. PATENT DOCUMENTS

	Document Number <small>Country Code-Number-Kind Code</small>	Date <small>MM-YYYY¹</small>	Name	Classification ²	
A	5,236,704	8/1993	Fujioka et al.	424	85.1
B					
C					
D					
E					
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M					

FOREIGN PATENT DOCUMENTS

	Document Number <small>Country Code-Number-Kind Code</small>	Date <small>MM-YYYY¹</small>	Country	Name	Classification ²	
N	WO 96/40265	12/1996	WIPO	Szoka et al.	----	----
O	WO 96/29096	3/1996	JPN	Kuma et al.	----	----
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NON-PATENT DOCUMENTS

Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages					
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